
EE230-02 RFIC II

Fall 2018

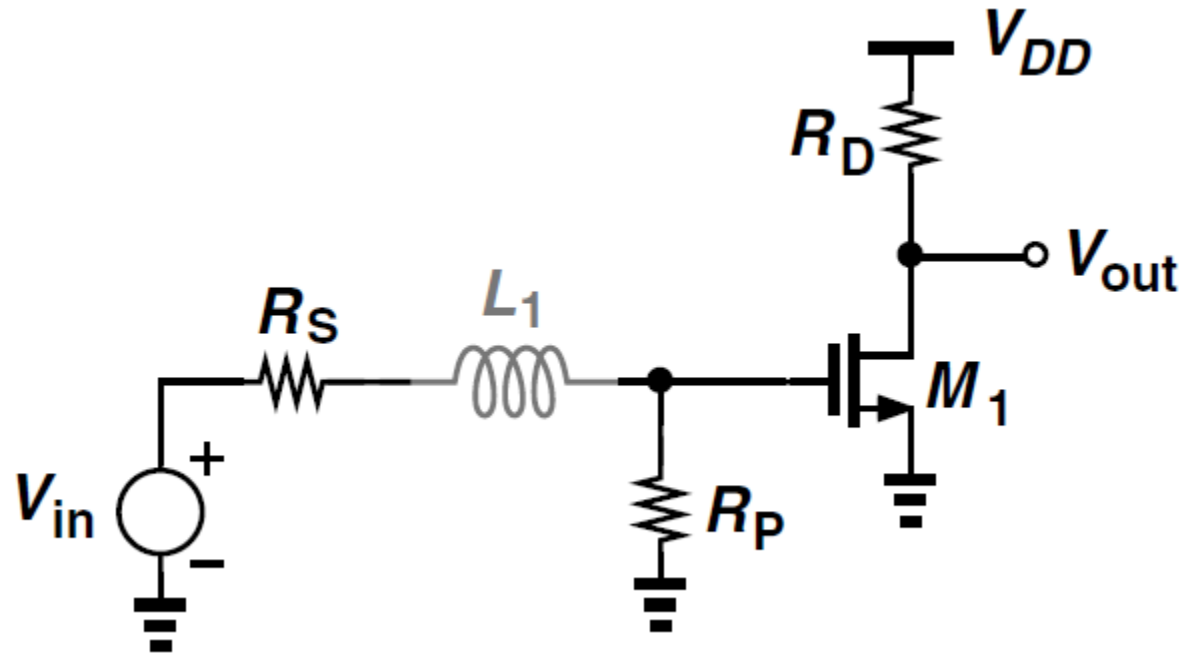
Lecture 7: LNA2

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LNA Topologies

Common–Source Stage with	Common–Gate Stage with	Broadband Topologies
<ul style="list-style-type: none">■ Inductive Load■ Resistive Feedback■ Cascode, Inductive Load, Inductive Degeneration	<ul style="list-style-type: none">■ Inductive Load■ Feedback■ Feedforward■ Cascode and Inductive Load	<ul style="list-style-type: none">■ Noise–Cancelling LNAs■ Reactance–Cancelling LNAs

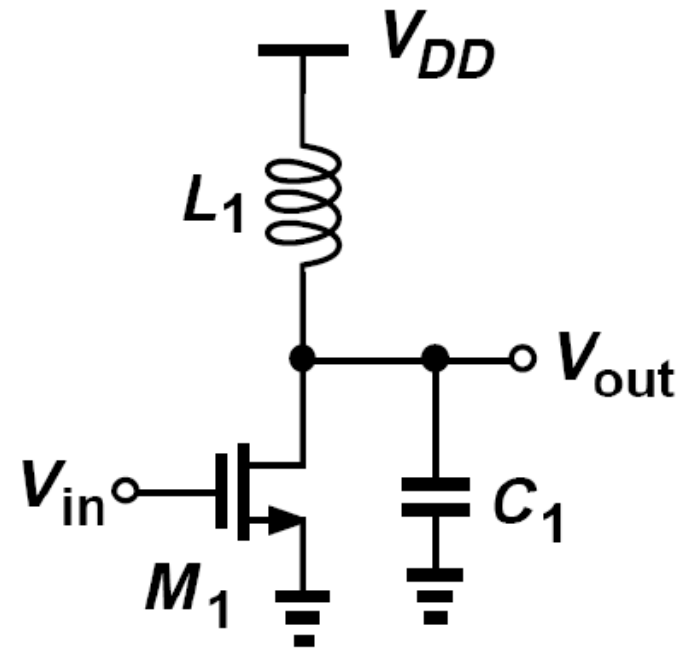
Resistor Input Matching



For $R_P \approx R_S$, the NF exceeds 3 dB—perhaps substantially.

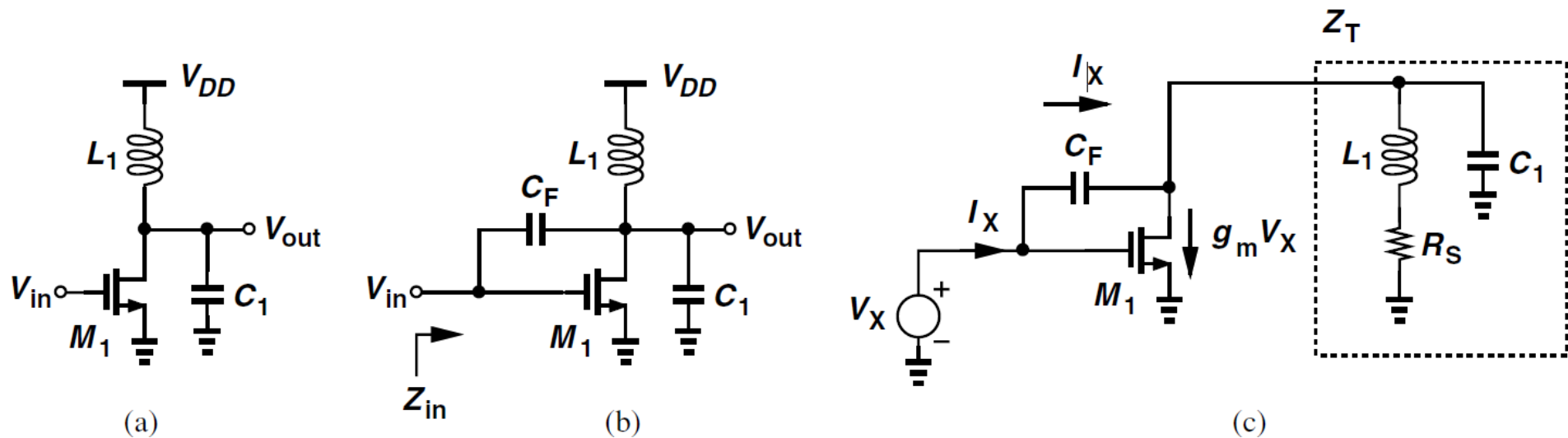
Common Source with Inductive Load

- Can operate with very low supply voltages
- L_1 resonates with the total capacitance at the output node, affording a much higher operation frequency than does the resistively-loaded counterpart



How about the input matching?

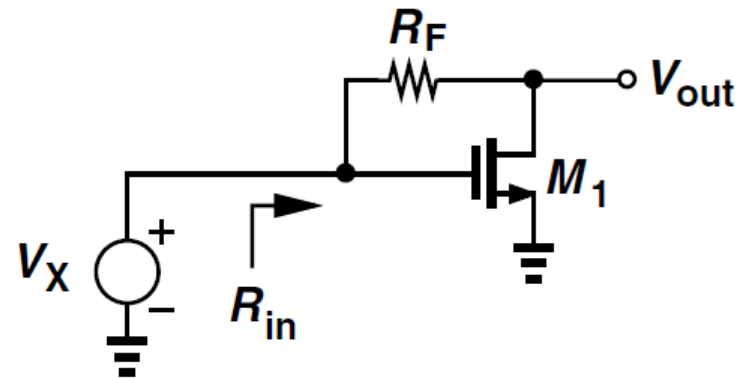
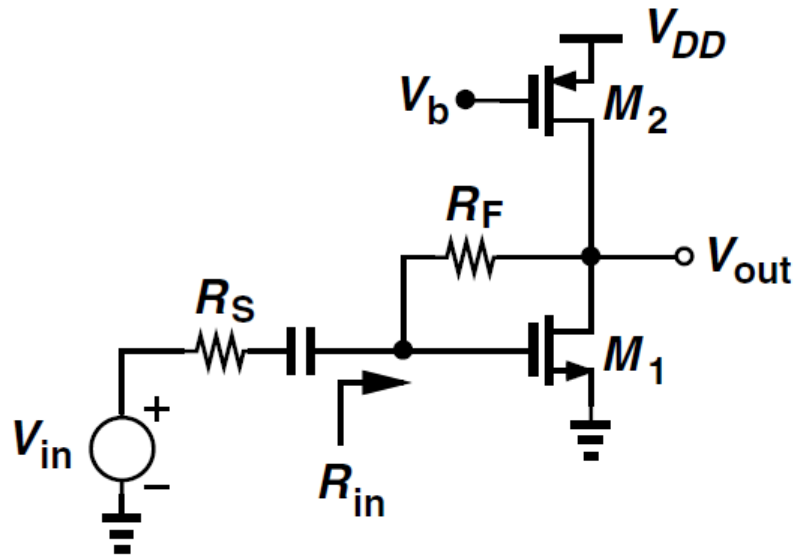
Common Source with Inductive Load



$$Z_{in}(s) = \frac{V_X}{I_X} = \frac{L_1(C_1 + C_F)s^2 + R_S(C_1 + C_F)s + 1}{[L_1C_1s^2 + (R_SC_1 + g_mL_1)s + 1 + g_mR_S]C_Fs}$$

While providing the possibility of $\text{Re}\{Z_{in}\} = 50 \, \Omega$ at the frequency of interest, the feedback capacitance C_F gives rise to a negative input resistance at other frequencies, potentially causing instability.

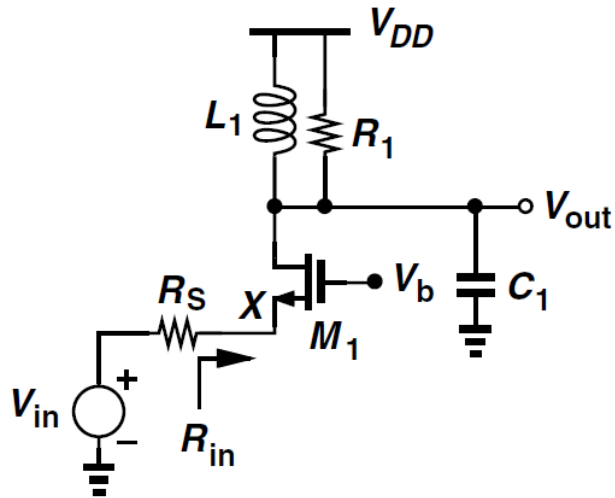
Common Source with Resistive Feedback



$$\text{NF} \approx 1 + \frac{4R_S}{R_F} + \gamma + \gamma g_{m2}R_S$$

For $\gamma \approx 1$, the NF exceeds 3 dB even if $4R_S/R_F + \gamma g_{m2}R_S \ll 1$.

Common Gate LNA



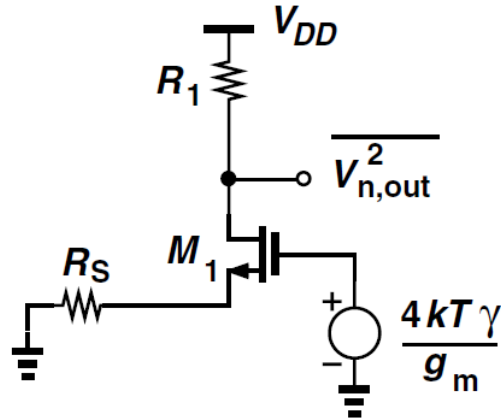
$$R_{in} = 1/g_m$$

$$g_m = 1/R_S = (50\ \Omega)^{-1}$$

$$\frac{V_{out}}{V_X} = g_m R_1 = \frac{R_1}{R_S}$$

$$V_{out}/V_{in} = R_1/(2R_S)$$

Common Gate Noise Figure



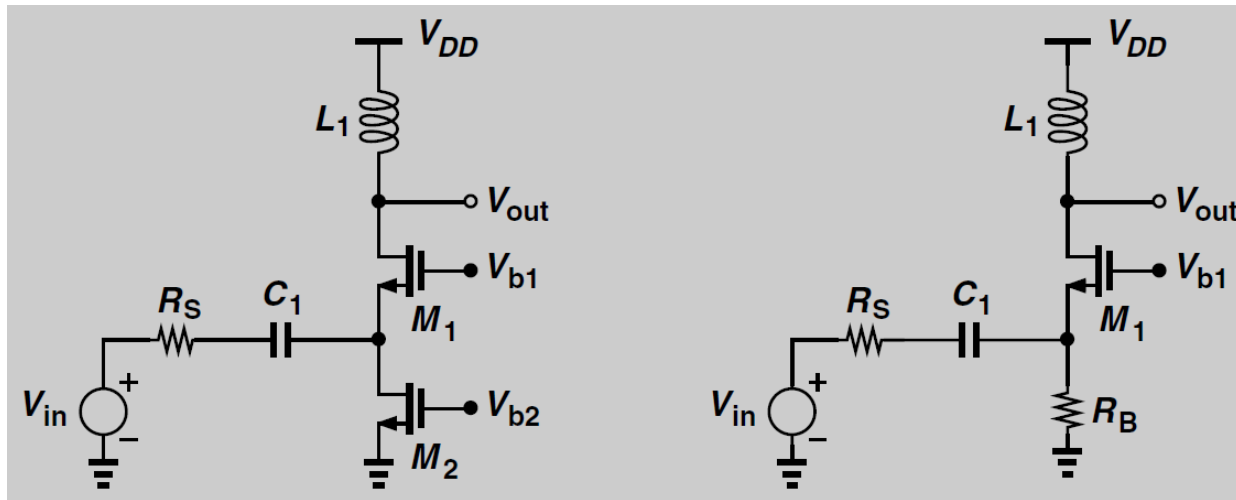
$$\overline{V_{n,out}^2}|_{M1} = \frac{4kT\gamma}{g_m} \left(\frac{R_1}{R_S + \frac{1}{g_m}} \right)^2 = kT\gamma \frac{R_1^2}{R_S}$$

$$NF = \frac{\text{Total Output Noise}}{\text{Output Noise due to Source}} = 1 + \frac{\text{Noise due to Circuit}}{\text{Noise due to Source}}$$

$$= 1 + \frac{kT\gamma \frac{R_1^2}{R_S} + 4kTR_1}{4kTR_s \left(\frac{1}{2} g_m R_1 \right)^2} = 1 + \frac{kT\gamma \frac{R_1^2}{R_S} + 4kTR_1}{kTR_s \left(\frac{R_1}{R_S} \right)^2} = 1 + \gamma + \frac{4R_S}{R_1}$$

Even if $\frac{4R_S}{R_1} \ll 1 + \gamma$, the NF still reaches 3dB with $\gamma \approx 1$

Common Gate Bias



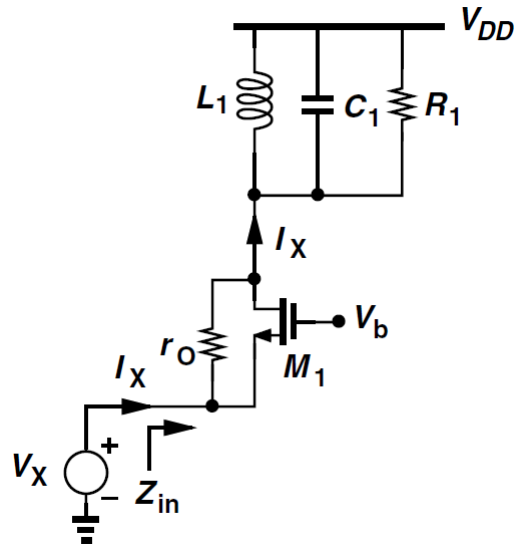
$$V_{DS2} \geq V_{GS2} - V_{TH2}$$

$$\begin{aligned} \overline{I_{n,M2}^2} &= 4kT\gamma g_{m2} \\ &= 4kT\gamma \frac{2I_D}{V_{GS2} - V_{TH2}} \end{aligned}$$

$$\begin{aligned} \overline{I_{n,RB}^2} &= \frac{4kT}{R_B} \\ &= 4kT \frac{I_D}{V_{RB}} \end{aligned}$$

Since $V_{GS2} - V_{TH2} \leq V_{RB}$, the noise contribution of M_2 is about twice that of R_B (for $\gamma \approx 1$). Additionally, M_2 may introduce significant capacitance at the input node.

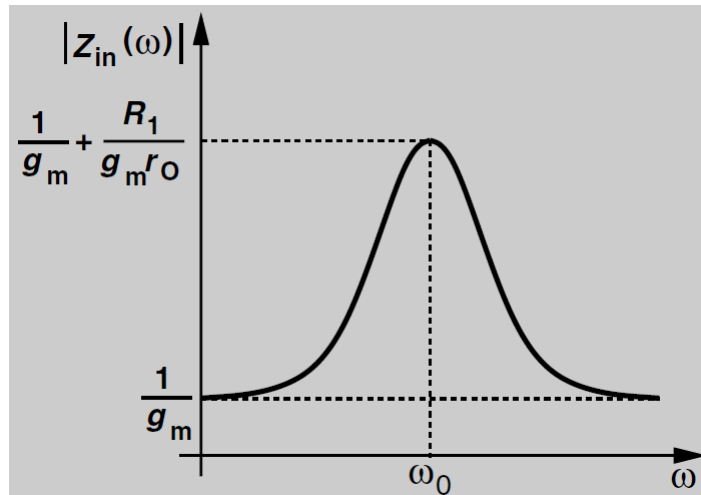
Common Gate Input Impedance



$$V_X = r_O(I_X - g_m V_X) + I_X R_1$$

$$\frac{V_X}{I_X} = \frac{R_1 + r_O}{1 + g_m r_O}$$

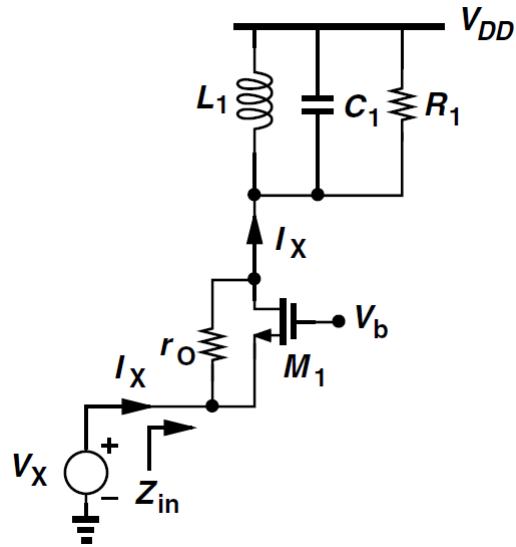
$$\approx 1/g_m + R_1/(g_m r_O)$$



For input matching,

$$R_S = \frac{R_1 + r_O}{1 + g_m r_O}$$

Common Gate Input Impedance



How about voltage gain?

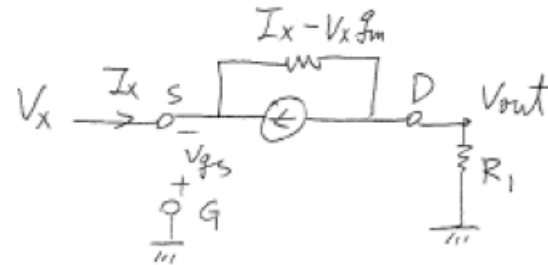
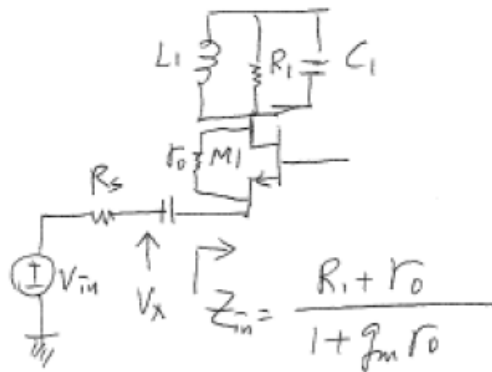
$$\frac{V_{out}}{V_{in}} = \frac{g_m r_O + 1}{r_O + g_m r_O R_S + R_S + R_1} R_1$$

$$R_S = \frac{R_1 + r_O}{1 + g_m r_O}$$

$$\frac{V_{out}}{V_{in}} = \frac{g_m r_O + 1}{2 \left(1 + \frac{r_O}{R_1} \right)}$$

This is a disturbing result! If r_O and R_1 are comparable, then the voltage gain is on the order of $g_m r_O / 4$, a very low value.

Common Gate Voltage Gain

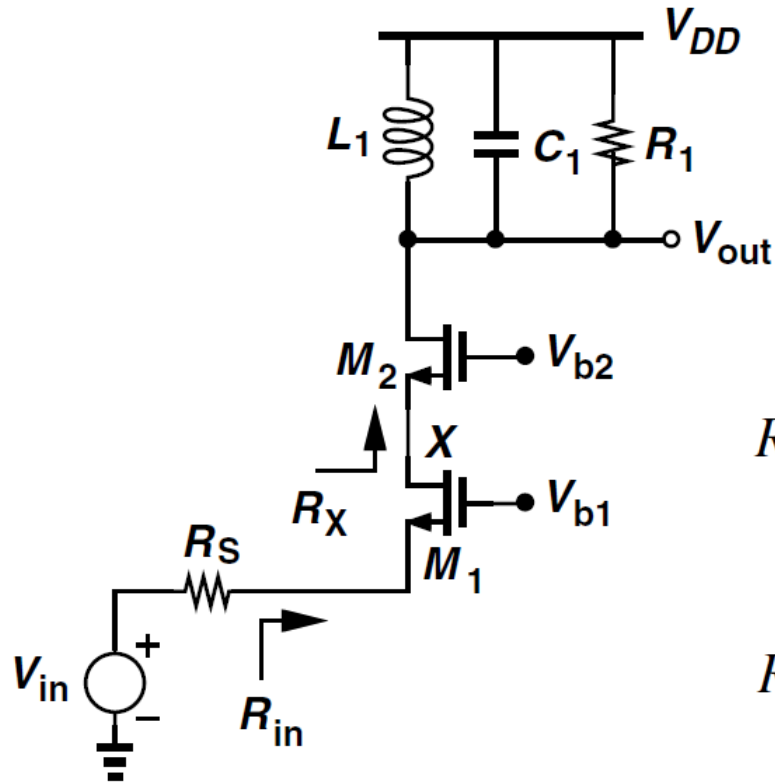


$$\frac{V_{out}}{V_x} = \frac{I_x R_L}{I_x \cdot Z_{in}} = \frac{R_L}{Z_{in}} = \frac{R_L (1 + g_m r_o)}{(R_L + r_o)}$$

$$\begin{aligned} \frac{V_{out}}{V_{in}} &= \frac{V_{out}}{V_x} \cdot \frac{V_x}{V_{in}} = \left[\frac{R_L (1 + g_m r_o)}{R_L + r_o} \right] \cdot \left[\frac{Z_{in}}{R_s + Z_{in}} \right] = \left[\frac{R_L (1 + g_m r_o)}{R_L + r_o} \right] \cdot \left[\frac{\left(\frac{R_L + r_o}{1 + g_m r_o} \right)}{R_s + \left(\frac{R_L + r_o}{1 + g_m r_o} \right)} \right] \\ &= \frac{R_L (1 + g_m r_o)}{r_o + g_m r_o R_s + R_s + R_L} \quad \# \end{aligned}$$

$$\text{when } R_s \approx \frac{R_L + r_o}{1 + g_m r_o} \Rightarrow \frac{V_{out}}{V_{in}} \approx \frac{(1 + g_m r_o)}{2 \left(1 + \frac{r_o}{R_L} \right)} \approx \frac{g_m r_o}{4} \quad \text{if } r_o \approx R_L$$

Cascode Common Gate Stage



$$R_X = \frac{R_1 + r_{O2}}{1 + g_{m2}r_{O2}}$$

$$R_{in} = \left(\frac{R_1 + r_{O1}}{1 + g_{m2}r_{O2}} + r_{O1} \right) \div (1 + g_{m1}r_{O1})$$

$$R_{in} \approx \frac{1}{g_{m1}} + \frac{R_1}{g_{m1}r_{O1}g_{m2}r_{O2}} + \frac{1}{g_{m1}r_{O1}g_{m2}}$$

The addition of the cascode device entails two issues: the noise contribution of M_2 and the voltage headroom limitation due to stacking two transistors.

Noise From M_2

